

## Complementary MOSFET

### DESCRIPTION

The SMC4545 is the N+P Complementary mode power field effect transistors are using trench DMOS technology. advanced trench technology to provide excellent  $R_{DS(ON)}$ . This device is widely preferred for commercial-industrial surface mount applications and suited for low voltage applications such.

### PART NUMBER INFORMATION

**SMC 4545 M - TR G**  
 a      b      c      d      e

- a : Company name.
- b : Product Serial number.
- c : Package code                      M:SOP-8
- d : Handling code                      TR:Tape&Reel
- e : Green produce code    G:RoHS Compliant

### FEATURES

#### N-Channel

$V_{DS}=30V, I_D=7.8A$

$R_{DS(ON)}=16m\Omega(Typ.)@V_{GS}=10V$

$R_{DS(ON)}=20m\Omega(Typ.)@V_{GS}=4.5V$

#### P-Channel

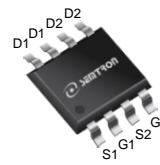
$V_{DS}=-30V, I_D=-5.3A$

$R_{DS(ON)}=38m\Omega(Typ.)@V_{GS}=-10V$

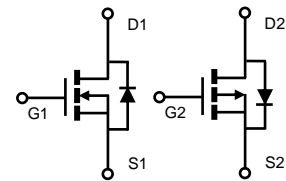
$R_{DS(ON)}=56m\Omega(Typ.)@V_{GS}=-4.5V$

### APPLICATIONS

- ◆ High Frequency Synchronous Buck DC-DC Converter
- ◆ Portable Equipment and Battery Powered



SOP-8



N-ch

P-ch

### ABSOLUTE MAXIMUM RATINGS ( $T_A = 25^\circ C$ Unless otherwise noted)

Symbol	Parameter	Rating		Units	
		N-ch	P-ch		
$V_{DSS}$	Drain-Source Voltage	30	-30	V	
$V_{GSS}$	Gate-Source Voltage	$\pm 20$	$\pm 20$	V	
$I_D$	Continuous Drain Current	$T_A=25^\circ C$	7.8	-5.3	A
		$T_A=70^\circ C$	6.4	-4.2	A
$I_{DM}$	Pulsed Drain Current <sup>A</sup>	31.2	-21.2	A	
$I_{AS}$	Avalanche Current <sup>A</sup>	15	-15	A	
$E_{AS}$	Single Pulse Avalanche energy $L=0.3mH$ <sup>AE</sup>	33	33	mJ	
$P_D$	Power Dissipation <sup>B</sup>	$T_A=25^\circ C$	2	2	W
		$T_A=70^\circ C$	1.3	1.3	W
$T_J$	Operation Junction Temperature	-55/150		$^\circ C$	
$T_{STG}$	Storage Temperature Range	-55/150		$^\circ C$	

### THERMAL RESISTANCE

Symbol	Parameter	Typ	Max	Units
$R_{\theta JA}$	Thermal Resistance Junction to Ambient <sup>B</sup>	$t \leq 10s$	62	$^\circ C/W$
	Thermal Resistance Junction to Ambient <sup>BC</sup>	Steady-State	90	

## ■ N-ch ELECTRICAL CHARACTERISTICS ( $T_A = 25^\circ\text{C}$ Unless otherwise noted)

Symbol	Parameter	Condition	Min	Typ	Max	Unit
<b>Static Parameters</b>						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =250 $\mu$ A	30			V
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250 $\mu$ A	1	1.5	2	V
I <sub>GSS</sub>	Gate Leakage Current	V <sub>DS</sub> =0V, V <sub>GS</sub> = $\pm$ 20V			$\pm$ 100	nA
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =30V, V <sub>GS</sub> =0V, T <sub>J</sub> =25 $^\circ$ C			1	$\mu$ A
		V <sub>DS</sub> =24V, V <sub>GS</sub> =0V, T <sub>J</sub> =75 $^\circ$ C			10	
R <sub>DS(ON)</sub>	Drain-source On-Resistance <sup>D</sup>	V <sub>GS</sub> =10V, I <sub>D</sub> =7.8A		16	20	m $\Omega$
		V <sub>GS</sub> =4.5V, I <sub>D</sub> =6A		20	26	
G <sub>fs</sub>	Forward Transconductance	V <sub>DS</sub> =10V, I <sub>D</sub> =6A		6		S
<b>Diode Characteristics</b>						
V <sub>SD</sub>	Diode Forward Voltage <sup>D</sup>	I <sub>S</sub> =1A, V <sub>GS</sub> =0V			1	V
I <sub>S</sub>	Diode Continuous Forward Current				7.8	A
t <sub>rr</sub>	Reverse Recovery Time	I <sub>S</sub> =6A, dI/dt=100A/ $\mu$ s		12.5		ns
Q <sub>rr</sub>	Reverse Recovery Charge	T <sub>J</sub> =25 $^\circ$ C		3.2		nC
<b>Dynamic and Switching Parameters <sup>E</sup></b>						
Q <sub>g</sub>	Total Gate Charge	V <sub>DS</sub> =15V, V <sub>GS</sub> =10V, I <sub>D</sub> =6A		12.7	17.8	nC
Q <sub>g</sub>	Total Gate Charge (4.5V)			6.2	8.7	
Q <sub>gs</sub>	Gate-Source Charge			2.4	3.4	
Q <sub>gd</sub>	Gate-Drain Charge			2	2.8	
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> =15V, V <sub>GS</sub> =0V, f=1MHz		550		pF
C <sub>oss</sub>	Output Capacitance			78		
C <sub>rss</sub>	Reverse Transfer Capacitance			62		
t <sub>d(on)</sub>	Turn-On Time	V <sub>DD</sub> =15V, V <sub>GEN</sub> =10V R <sub>G</sub> =3.3 $\Omega$ , I <sub>D</sub> =1A		2.5	5	nS
t <sub>r</sub>				7.6	14	
t <sub>d(off)</sub>	Turn-Off Time			19.8	38	
t <sub>f</sub>				4.2	8	

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged.

- A. Surface mounted on FR4 board using 1 in<sup>2</sup> pad size.
- B. Pulsed width limited by maximum junction temperature, T<sub>J(MAX)</sub>=150 $^\circ$ C.
- C. Using  $\leq$  10s junction-to-ambient thermal resistance is base on T<sub>J(MAX)</sub>=150 $^\circ$ C.
- D. Pulse test width  $\leq$ 300 $\mu$ s and duty cycle  $\leq$  2%.
- E. Guaranteed by design, not subject to production testing.

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## ■ P-ch ELECTRICAL CHARACTERISTICS ( $T_A = 25^\circ\text{C}$ Unless otherwise noted)

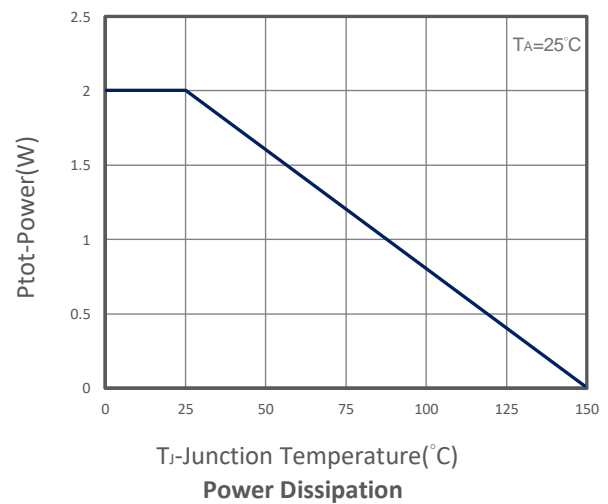
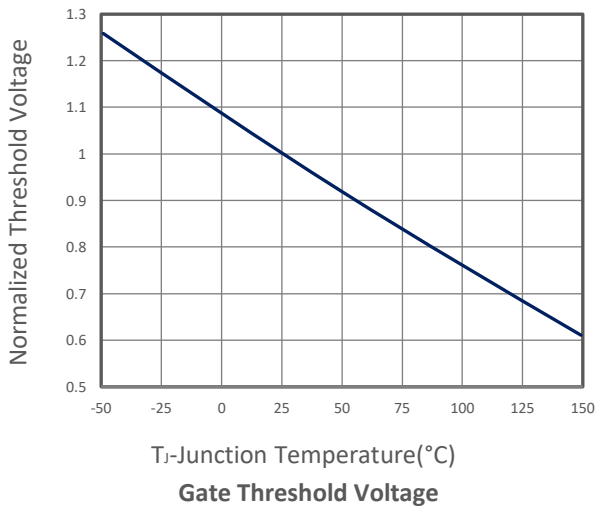
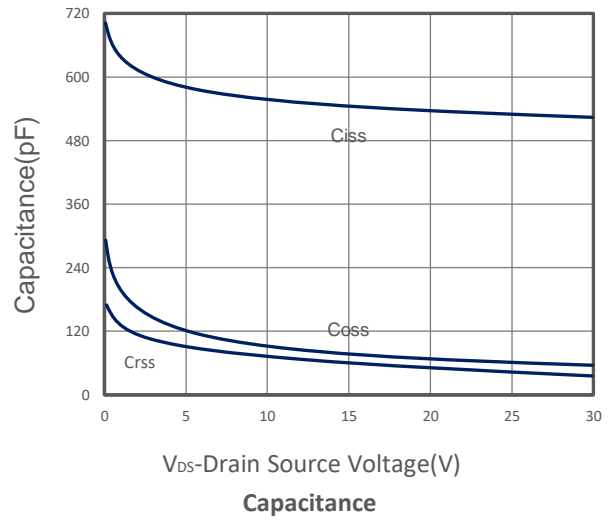
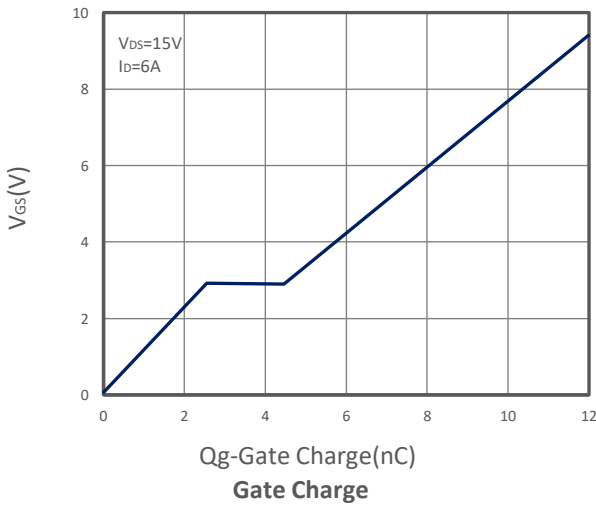
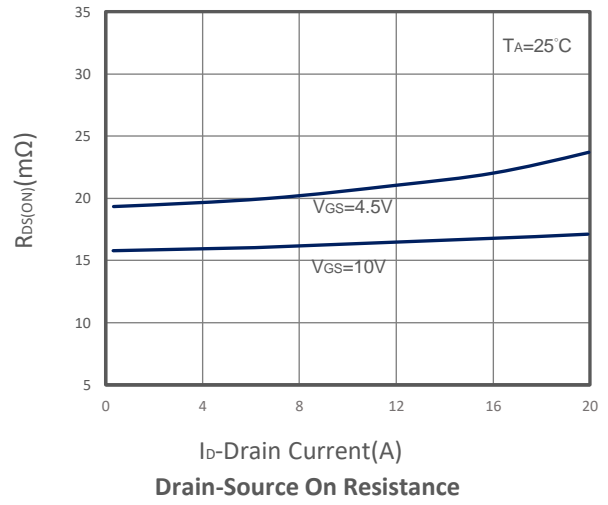
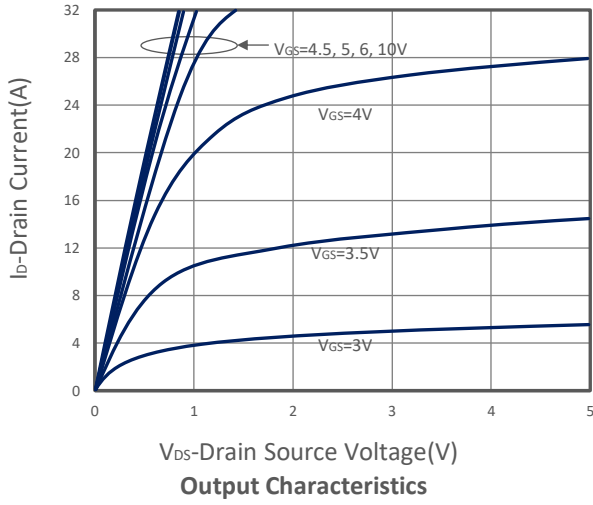
Symbol	Parameter	Condition	Min	Typ	Max	Unit
<b>Static Parameters</b>						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =-250 $\mu$ A	-30			V
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250 $\mu$ A	-1	-1.5	-2	V
I <sub>GSS</sub>	Gate Leakage Current	V <sub>DS</sub> =0V, V <sub>GS</sub> = $\pm$ 20V			$\pm$ 100	nA
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =-30V, V <sub>GS</sub> =0V, T <sub>J</sub> =25 $^\circ$ C			-1	$\mu$ A
		V <sub>DS</sub> =-24V, V <sub>GS</sub> =0V, T <sub>J</sub> =75 $^\circ$ C			-10	
R <sub>DS(ON)</sub>	Drain-source On-Resistance <sup>D</sup>	V <sub>GS</sub> =-10V, I <sub>D</sub> =-5.3A V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-4A		38 56	45 60	m $\Omega$
G <sub>fs</sub>	Forward Transconductance	V <sub>DS</sub> =-10V, I <sub>D</sub> =-4.5A		12		S
<b>Diode Characteristics</b>						
V <sub>SD</sub>	Diode Forward Voltage <sup>D</sup>	I <sub>S</sub> =-1A, V <sub>GS</sub> =0V			-1	V
I <sub>S</sub>	Diode Continuous Forward Current				-5.3	A
t <sub>rr</sub>	Reverse Recovery Time	I <sub>S</sub> =-4.5A, di/dt=100A/ $\mu$ s		8.1		ns
Q <sub>rr</sub>	Reverse Recovery Charge	T <sub>J</sub> =25 $^\circ$ C		2.7		nC
<b>Dynamic and Switching Parameters<sup>E</sup></b>						
Q <sub>g</sub>	Total Gate Charge	V <sub>DS</sub> =-15V, V <sub>GS</sub> =-10V I <sub>D</sub> =-4.5A		13.9	19.5	nC
Q <sub>g</sub>	Total Gate Charge (4.5V)			6.8	9.5	
Q <sub>gs</sub>	Gate-Source Charge			2.9	4.1	
Q <sub>gd</sub>	Gate-Drain Charge			3.5	4.9	
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> =-15V, V <sub>GS</sub> =0V, f=1MHz		750		pF
C <sub>oss</sub>	Output Capacitance			95		
C <sub>rss</sub>	Reverse Transfer Capacitance			82		
t <sub>d(on)</sub>	Turn-On Time	V <sub>DD</sub> =-15V, V <sub>GEN</sub> =-10V R <sub>G</sub> =6 $\Omega$ , I <sub>D</sub> =-1A		4	8	nS
t <sub>r</sub>				10	19	
t <sub>d(off)</sub>	Turn-Off Time			28.5	42	
t <sub>f</sub>				7.6	14	

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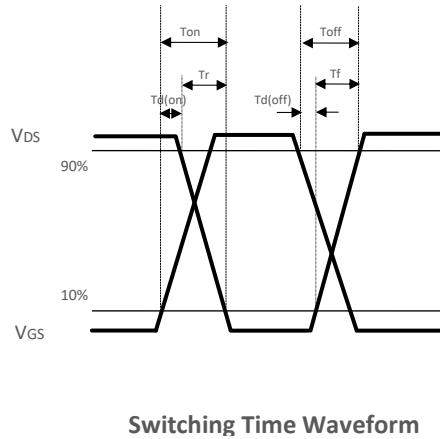
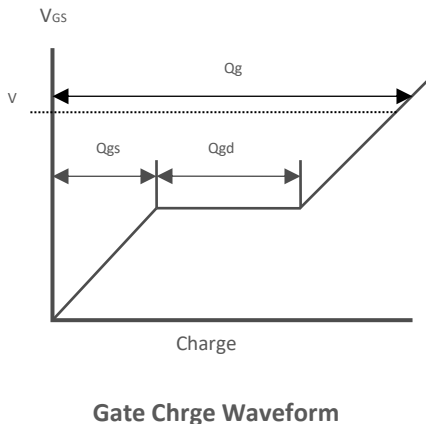
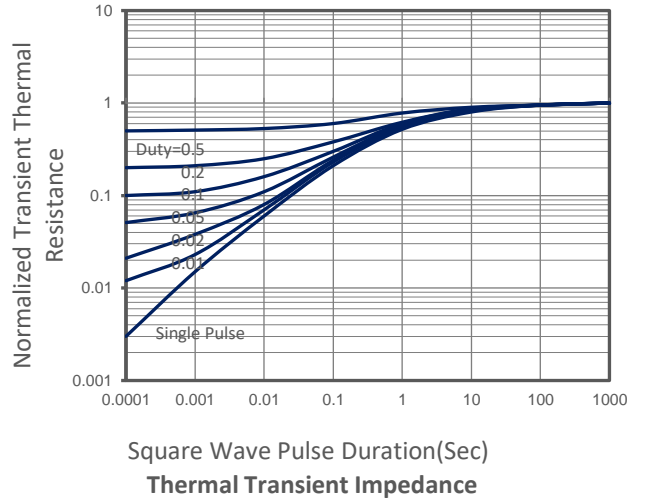
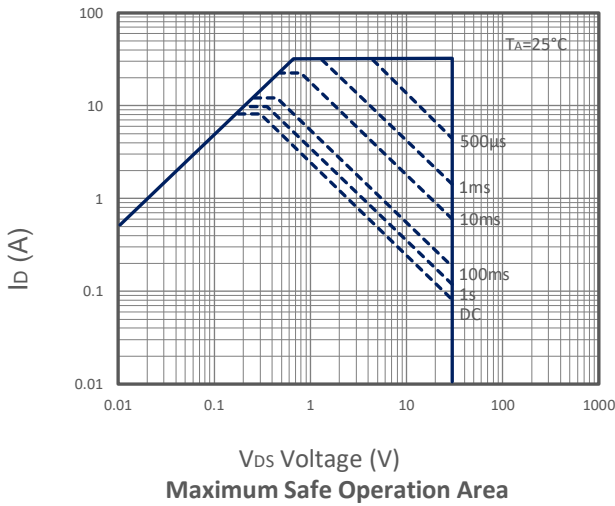
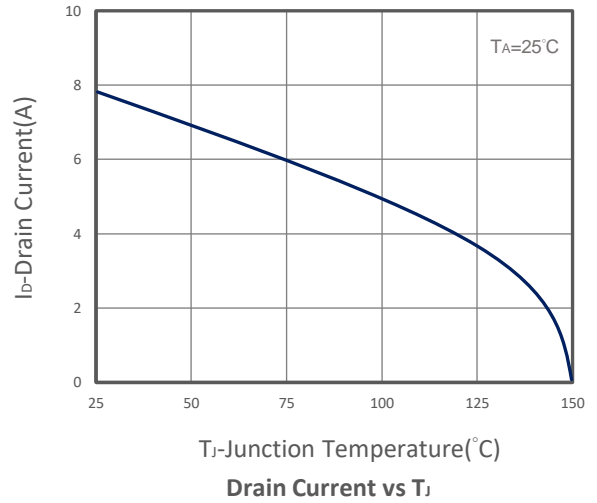
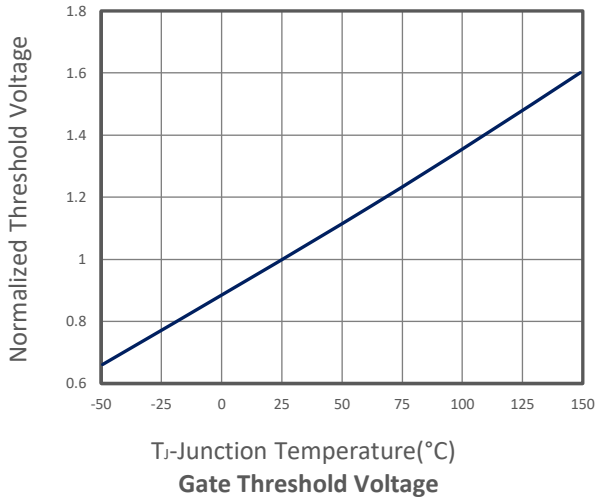
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- B. Pulsed width limited by maximum junction temperature, T<sub>J(MAX)</sub>=150 $^\circ$ C.
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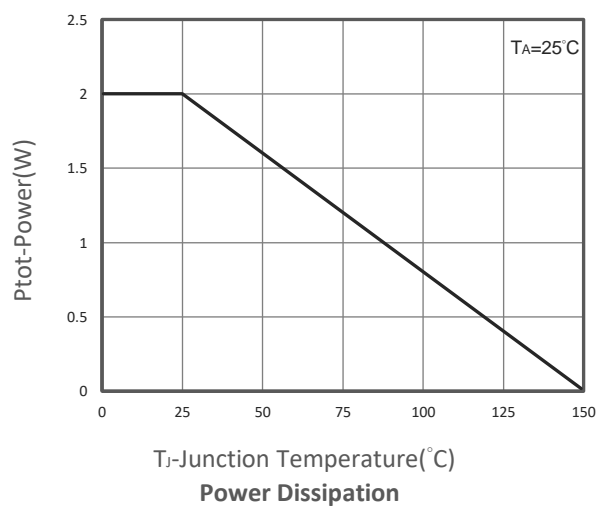
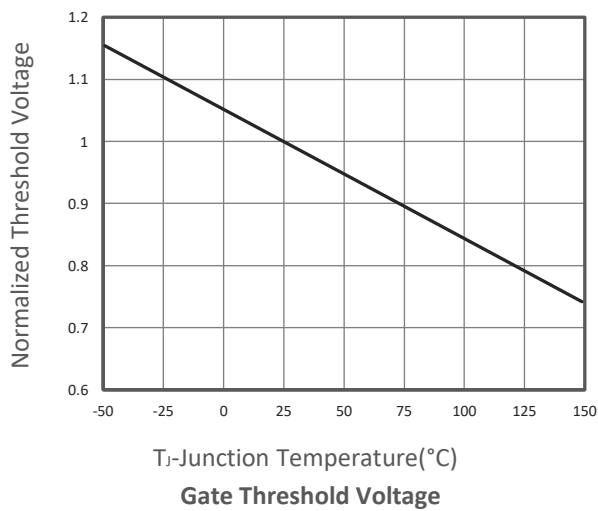
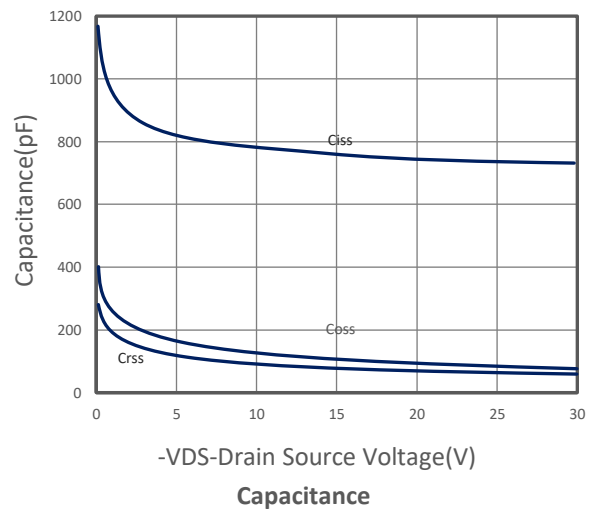
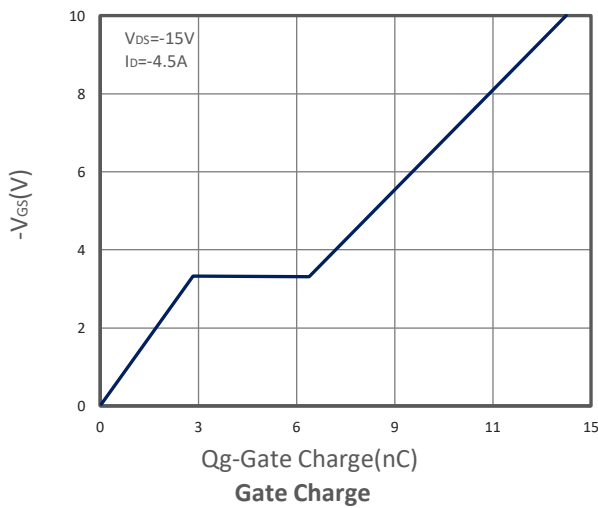
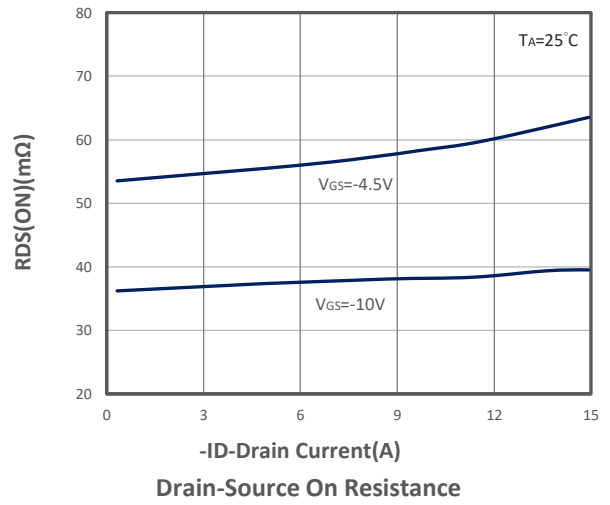
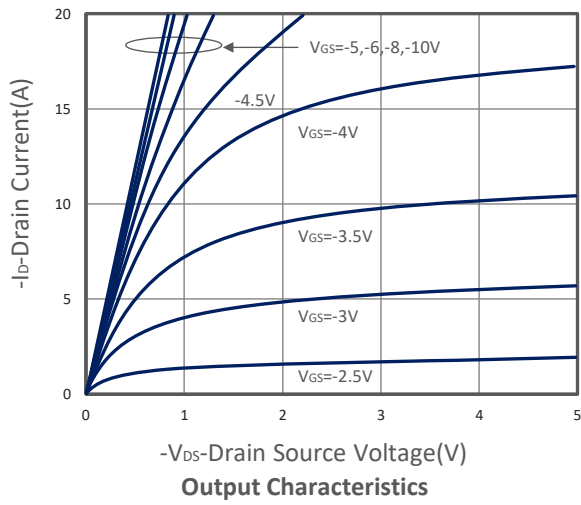
## N-ch TYPICAL CHARACTERISTICS



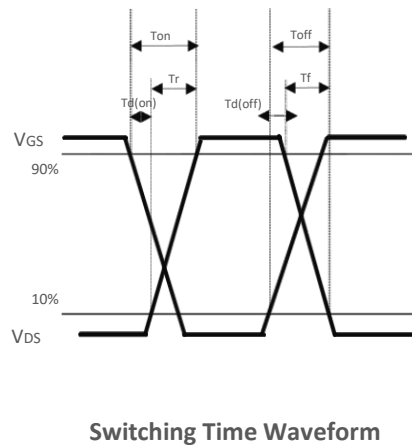
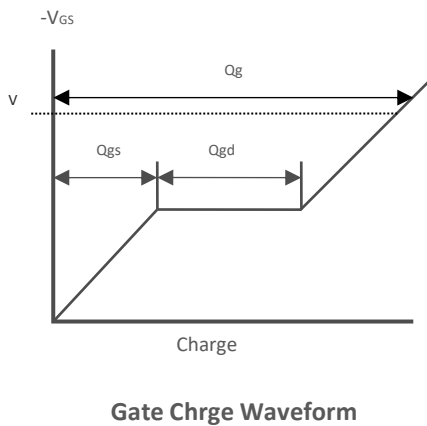
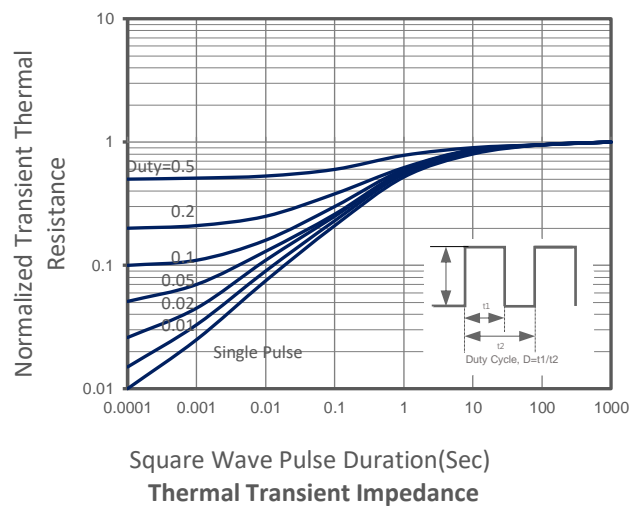
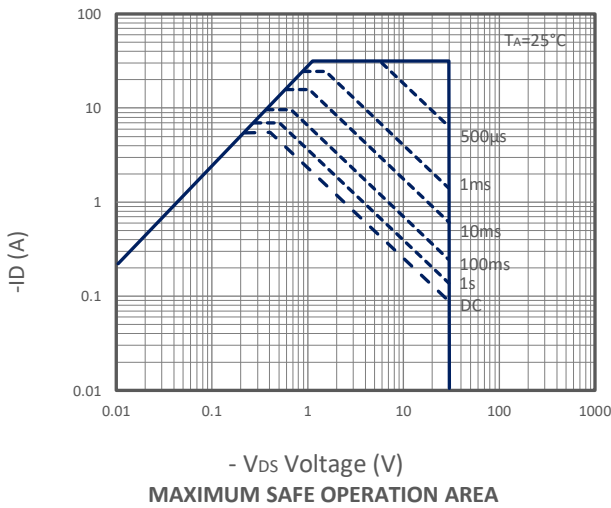
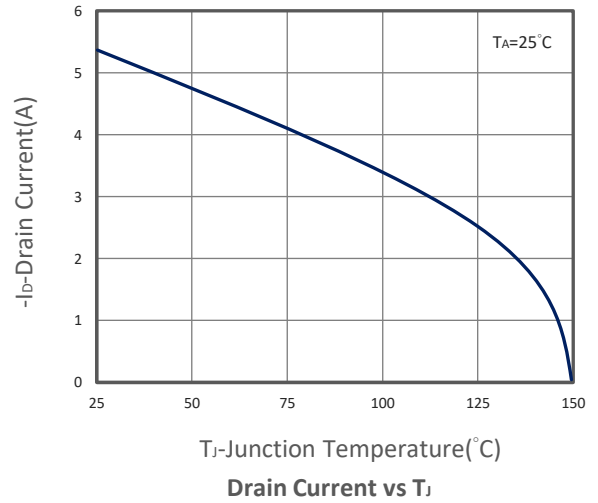
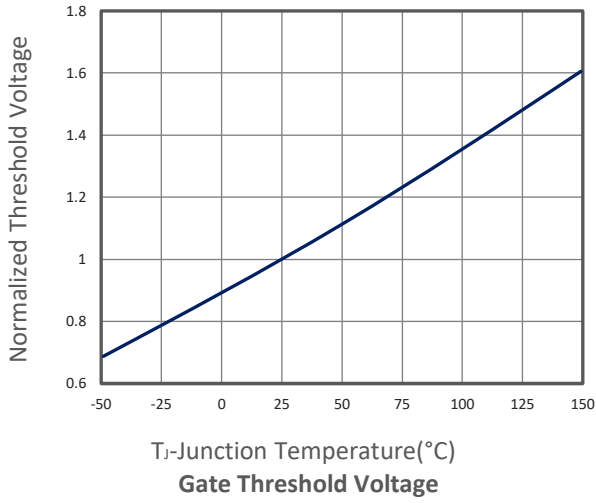
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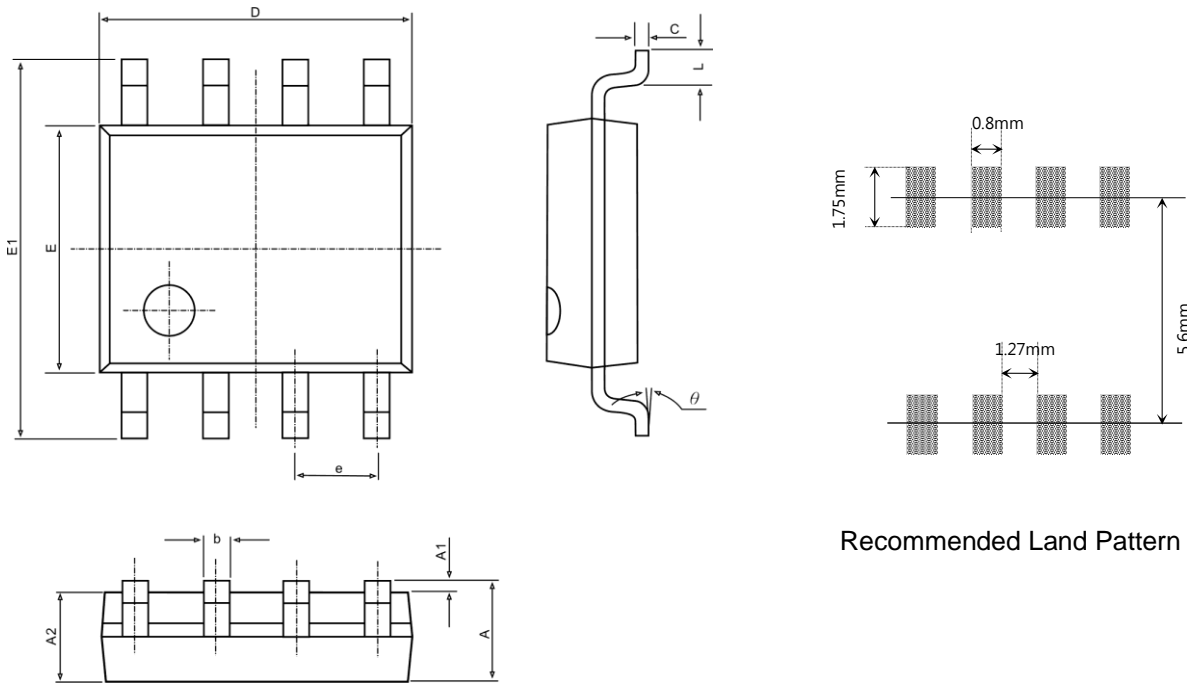
## P-ch TYPICAL CHARACTERISTICS



## P-ch TYPICAL CHARACTERISTICS



## ■ SOP-8 PACKAGE DIMENSIONS



Recommended Land Pattern

Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	1.350	1.750	0.053	0.069
A1	0.100	0.250	0.040	0.010
A2	1.350	1.550	0.053	0.061
b	0.330	0.510	0.130	0.020
c	0.170	0.250	0.006	0.010
D	4.700	5.100	0.185	0.200
E	3.800	4.000	0.150	0.157
E1	5.800	6.200	0.228	0.244
e	1.270BSC.		0.050BSC.	
L	0.400	1.270	0.016	0.005
θ	0°	8°	0°	8°